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 19 , Issue: 7 , July 1997
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Wiskott, L.; Fellous, J.-M.; Kruger, N.; von der Malsburg, C.;
 Image Processing, 1997. Proceedings., International Conference on , Volume
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Monacos, S.P.; Morookian, J.M.; Davis, L.; Bergman, L.A.; Forouhar, S.; Sau J.R.;
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